TLP561J

Triac Driver Programmable Controllers AC-Output Module Solid State Relay

The TOSHIBA TLP561J consists of a zero voltage crossing turn-on photo-triac optically coupled to a gallium arsenide infrared emitting diode in a six lead plastic DIP package.

- Peak off-state voltage: 600V(min.)
- On-state current: 100mA(max.)
- Isolation voltage: 2500V_{rms}(min.)
- UL recognized: UL1577, file no. E67349
- Isolation operating voltage: $2500V_{ac}\ \text{or}\ 300V_{dc}$ for isolation

Groupe C*1

• Trigger LED current

Classi– Fication*	Trigger LED Current (mA)		Marking Of		
	V _T =6V, Ta=25°C		Classification		
	Min.	Max.			
(IFT7)	_	7	Т7		
Standard	—	10	T7, blank		

*Ex. (IFT7); TLP561J(IFT7)

(Note): Application type name for certification test, please use standard product type name, i.e. TLP561J(IFT7): TLP561J

*1: According to VDE0110, table 4.



Weight: 0.39g

Pin Configuration (top view)





2 : CATHODE

3 : N.C. 4 : TERMINAL 1

6 : TERMINAL 2

Unit in mm

Maximum Ratings (Ta = 25°C)

Characteristic			Symbol	Rating	Unit
	Forward current	١ _F	50	mA	
LED	Forward current derating (Ta ≥	ΔI _F / °C	-0.7	mA / °C	
	Peak forward current (100µs pu	Peak forward current (100µs pulse, 100pps)			Α
	Reverse voltage	V _R	5	V	
	Junction temperature	Tj	125	°C	
	Off-state output terminal voltag	V _{DRM}	600	V	
		Ta = 25°C	I	100	m ()
Detector	On-state RMS current	Ta = 70°C	I _{T(RMS)}	50	mA
	On–state current derating (Ta ≥	ΔI _T / °C	-1.1	mA / °C	
	Peak on-state current (100µs p	I _{TP}	2	А	
	Peak nonrepetitive surge currer (Pw = 10ms, DC = 10%)	I _{TSM}	1.2	А	
	Junction temperature	Tj	115	°C	
Storage temperature range			T _{stg}	-55~125	°C
Operating temperature range			T _{opr}	-40~100	°C
Lead soldering temperature (10s)			T _{sol}	260	°C
Isolation voltage (AC, 1min., R.H. ≤ 60%)			BV _S 2500		V _{rms}

Recommended Operating Conditions

Characteristic	Symbol	Min.	Тур.	Max.	Unit
Supply voltage	V _{AC}	_	_	240	Vac
Forward current	١ _F	15	20	25	mA
Peak on-state current	I _{TP}			—	А
Operating temperature	T _{opr}	-25	_	85	°C

Individual Electrical Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min.	Тур.	Max.	Unit
LED	Forward voltage	VF	I _F = 10mA	1.0	1.15	1.3	V
	Reverse current	I _R	V _R = 5 V	_	_	10	μA
	Capacitance	CT	V = 0, f = 1MHz	_	30	_	pF
Detector	Peak off-state current	IDRM	V _{DRM} = 600V	—	10	1000	nA
	Peak on-state voltage	V _{TM}	I _{TM} = 100mA	—	1.7	3.0	V
	Holding current	Ι _Η	—	—	0.6	-	mA
	Critical rate of rise of off-state voltage	dv / dt	V _{in} = 240V _{rms,} Ta = 85°C (Fig.1) 200	500	-	V / µs
	Critical rate of rise of commutating voltage	dv / dt(c)	V _{in} = 60V _{rms} , I _T = 15mA (Fig.1) –	0.2	_	V / µs

Coupled Electrical Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Trigger LED current	I _{FT}	$V_{T} = 6V, R_{L} = 100\Omega$	_	5	10	mA
Inhibit voltage	VIH	I _F = Rated I _{FT}	_	_	50	V
Leakage in inhibited state	Ιн	I _F = Rated I _{FT} V _T = Rated V _{DRM}	-	200	600	μA
Capacitance (input to output)	CS	V _S = 0, f = 1MHz		0.8	_	pF
Isolation resistance	R _S	V _S = 500V	5×10 ¹⁰	10 ¹⁴	_	Ω
	BVS	AC, 1 minute	2500	_	_	V _{rms}
Isolation voltage		AC, 1 second, in oil	_	5000	_	
		DC, 1 minute, in oil	_	5000	_	V _{dc}

Fig.1: dv / dt test circuit



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